

Notice of References Cited	Application/Control No. 10/743,947		Applicant(s)/Patent Under Reexamination FUKUTA ET AL.	
	Examiner Benjamin Huh		Art Unit 3767	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,217,200	08-1980	Kedem et al.	204/633
*	B	US-5,169,382	12-1992	Theeuwes et al.	604/20
*	C	US-2005/0070840 a1	03-2005	Matsumura et al.	604/020
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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